Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/510,243	JENEY, PETER
Examiner	Art Unit

3742

Quang T. Van

SEARCHED						
Class	Subclass	Date	Examiner			
373	157,151 152,153 155-156	4/24/96	ær 1			
	162-164					
219	635,609					
	629,650					
	651					
117	222,224					
117	81					
428	212,216					
118	212,216					
	421		1			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		-			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East search Inventor check	4/24/06 5/01/06	AV AV		